

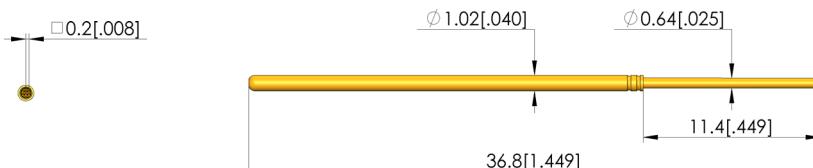


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- Long-stroke test probe for implementing combined ICT and FCT in a dual-stage fixture
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available. spring forces.
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles



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**General data**

Product group: ICT / FCT (in-circuit test and function test)
 Sub-product group: Bead probe
 Series: GKS-035
 Grid: 1.91 mm [75.1 mil]
 Contacting from: Post
 Magnetic: Yes
 Installation type: Plug-in
 Quick-exchange system: Yes
 Adjustable installation height: No
 Non-rotating: No
 Compatible receptacle(s): KS-075
 Min. temperature: -40 °C [-40 °F]
 Max. temperature: 80 °C [176 °F]
 RoHS-compliant: Yes

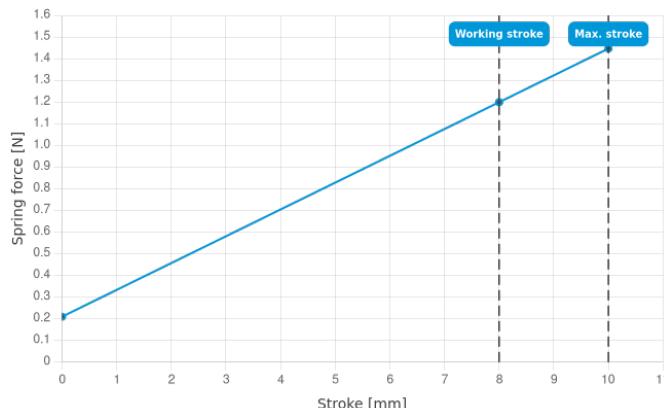
Test Probe GKS-035 360 064 A 1200

Item GKS-035-0057



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Partner for Future Technology



INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162
78467, Constance, Germany
Phone +49 7531 8105-0
Customer hotline +49 7531 8105-888
Fax +49 7531 8105-65
info@ingun.com



Prices and delivery times on request.
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ICT/FCT Test probes



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